N-Channel Power MOSFET

60 V, 220 A, 3.0 m Ω

Features

- Low R_{DS(on)}
- High Current Capability
- 100% Avalanche Tested
- These Devices are Pb-Free, Halogen Free and are RoHS Compliant
- NVB Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable

MAXIMUM RATINGS (T_J = 25°C Unless otherwise specified)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	60	V
Gate-to-Source Voltage	ge – Conti	nuous	V _{GS}	±20	V
Continuous Drain	Steady	T _A = 25°C	I _D	220	Α
Current, R _{θJC}	State	T _A = 100°C		156	
Power Dissipation, $R_{\theta JC}$	Steady State	T _A = 25°C	P _D	283	W
Pulsed Drain Current	t _p	= 10 μs	I _{DM}	660	Α
Current Limited by Package			I _{DMmax}	130	Α
Operating and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			Is	130	Α
Single Pulse Drain-to-Source Avalanche Energy (L = 0.3 mH)			E _{AS}	735	mJ
Lead Temperature for Soldering Purposes (1/8" from Case for 10 Seconds)			TL	260	°C

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Case (Drain) Steady State	$R_{\theta JC}$	0.53	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	28	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

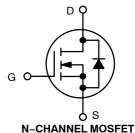
1. Surface mounted on FR4 board using 1 sq in pad size, (Cu Area 1.127 sq in [2 oz] including traces).

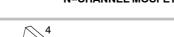


ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	(BR)DSS R _{DS(on)} MAX		
60 V	3.0 mΩ @ 10 V	220 A	
	3.6 mΩ @ 4.5 V	220 A	



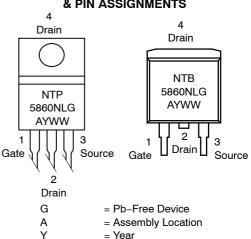






STYLE 2

MARKING DIAGRAMS & PIN ASSIGNMENTS



ORDERING INFORMATION

= Work Week

ww

1

See detailed ordering and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C Unless otherwise specified)

Characteristics	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	· ·			-	-	<u>-</u>	-
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{DS} = 0 V,	I _D = 250 μA	60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	I _D = 250 μA			6.1		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V V _{DS} = 60 V	T _J = 25°C			1.0	μΑ
		V _{GS} = 0 V V _{DS} = 60 V	T _J = 125°C			100	
Gate-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V	′ _{GS} = ±20 V			±100	nA
ON CHARACTERISTICS (Note 2)						•	
Gate Threshold Voltage	V _{GS(th)}	$V_{GS} = V_{DS}$	I _D = 250 μA	1.0		3.0	V
Threshold Temperature Coefficient	V _{GS(th)} /T _J				-7.7		mV/°C
Drain-to-Source On-Resistance	R _{DS(on)}	V _{GS} = 10 \	/, I _D = 20 A		2.4	3.0	mΩ
		V _{GS} = 4.5 \	V, I _D = 20 A		2.8	3.6	
Forward Transconductance	9 _{FS}	V _{DS} = 15 \	/, I _D = 30 A		47		S
CHARGES, CAPACITANCES & GATE RES	SISTANCE					•	
Input Capacitance	C _{iss}				13216		pF
Output Capacitance	C _{oss}	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1 MHz			1127		1
Transfer Capacitance	C _{rss}				752		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 48 V, I _D = 40 A			220		nC
Threshold Gate Charge	Q _{G(TH)}				13		
Gate-to-Source Charge	Q_{GS}				37		-
Gate-to-Drain Charge	Q_{GD}				54		
SWITCHING CHARACTERISTICS, V _{GS} = 1	10 V (Note 3)			•	•		•
Turn-On Delay Time	t _{d(on)}	V _{GS} = 10 V, V _{DD} = 48 V,			25		ns
Rise Time	t _r				58		1
Turn-Off Delay Time	t _{d(off)}	$I_{\rm D} = 100 {\rm A},$	$R_G = 2.5 \Omega$		98		
Fall Time	t _f	1			144		1
DRAIN-SOURCE DIODE CHARACTERIST	ics						
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V	T _J = 25°C		0.76	1.1	V_{dc}
		I _S = 40 A T _J = 125°C		0.60		1	
Reverse Recovery Time	t _{rr}	V _{GS} = 0 V, I _S = 100 A, dI _S /dt = 20 A/μs			50		ns
Charge Time	ta				25		1
Discharge Time	t _b				25		1
Reverse Recovery Stored Charge	Q _{RR}				71		nC

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

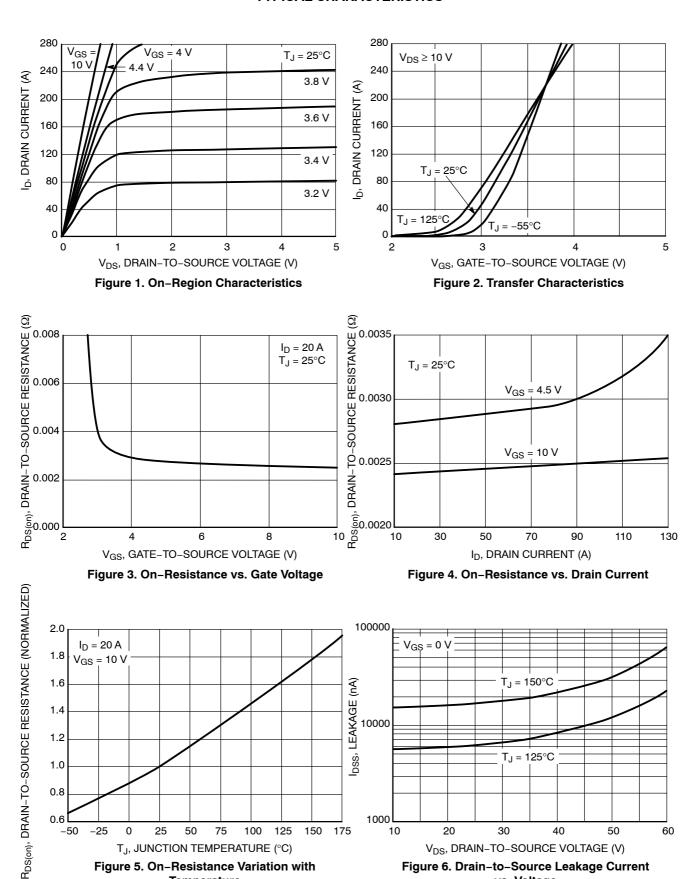


Figure 6. Drain-to-Source Leakage Current

vs. Voltage

Figure 5. On-Resistance Variation with

Temperature

TYPICAL CHARACTERISTICS

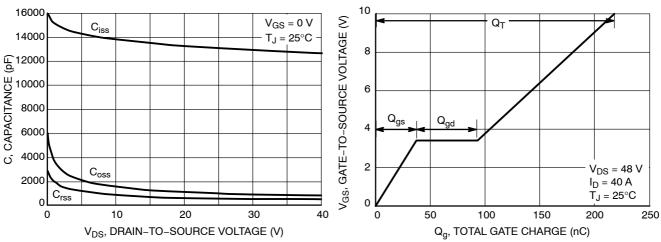


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source vs. Total Charge

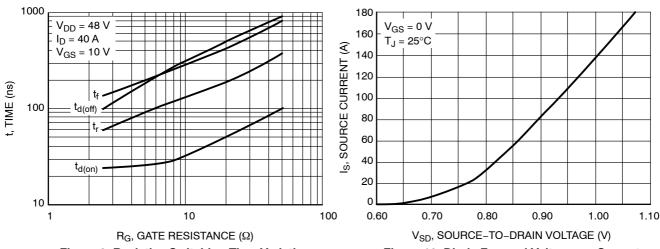


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

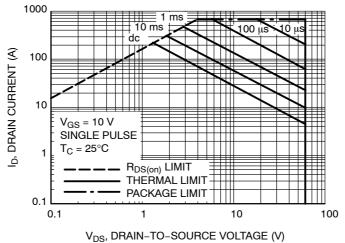


Figure 11. Maximum Rated Forward Biased
Safe Operating Area

TYPICAL CHARACTERISTICS

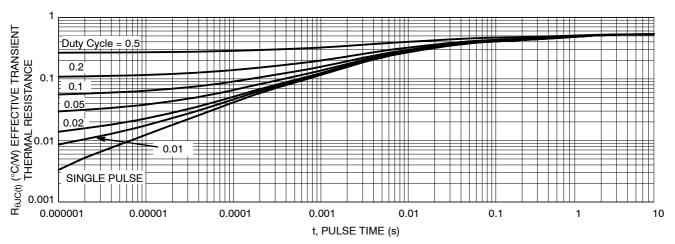


Figure 12. Thermal Response

ORDERING INFORMATION

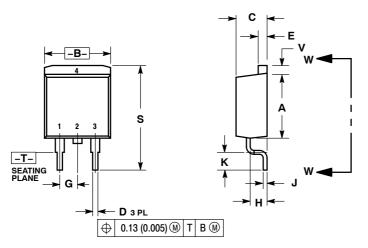
Device	Package	Shipping [†]
NTP5860NLG	TO-220AB (Pb-Free)	50 Units / Rail
NTB5860NLT4G	D ² PAK (Pb-Free)	800 / Tape & Reel
NVB5860NLT4G*	D ² PAK (Pb-Free)	800 / Tape & Reel

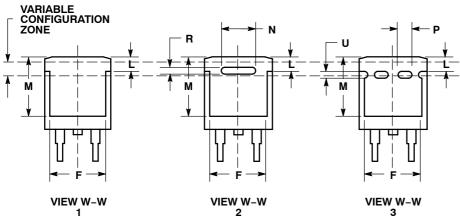
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

^{*}NVB Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable.

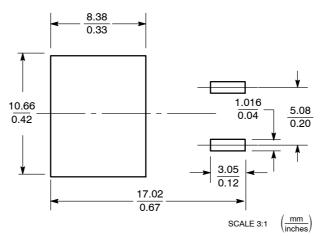
PACKAGE DIMENSIONS

D²PAK CASE 418B-04 **ISSUE J**





SOLDERING FOOTPRINT*



^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

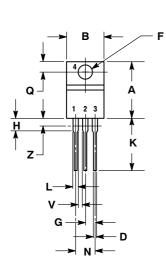
- NOTES:
 1. DIMENSIONING AND TOLERANCING
- PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.
- 418B-01 THRU 418B-03 OBSOLETE, NEW STANDARD 418B-04.

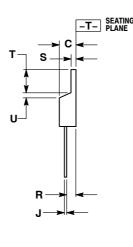
	INCHES		MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.340	0.380	8.64	9.65	
В	0.380	0.405	9.65	10.29	
С	0.160	0.190	4.06	4.83	
D	0.020	0.035	0.51	0.89	
Е	0.045	0.055	1.14	1.40	
F	0.310	0.350	7.87	8.89	
G	0.100	BSC	2.54 BSC		
Н	0.080	0.110	2.03	2.79	
7	0.018	0.025	0.46	0.64	
Κ	0.090	0.110	2.29	2.79	
L	0.052	0.072	1.32	1.83	
М	0.280	0.320	7.11	8.13	
N	0.197 REF		5.00 REF		
Р	0.079 REF		2.00 REF		
R	0.039 REF		0.99 REF		
S	0.575	0.625	14.60	15.88	
٧	0.045	0.055	1.14	1.40	

STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

PACKAGE DIMENSIONS

TO-220 CASE 221A-09 **ISSUE AF**





NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI
- Y14.5M, 1982. CONTROLLING DIMENSION: INCH.
- DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE

	INCHES		MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.570	0.620	14.48	15.75	
В	0.380	0.405	9.66	10.28	
С	0.160	0.190	4.07	4.82	
D	0.025	0.035	0.64	0.88	
F	0.142	0.161	3.61	4.09	
G	0.095	0.105	2.42	2.66	
Н	0.110	0.155	2.80	3.93	
J	0.014	0.025	0.36	0.64	
K	0.500	0.562	12.70	14.27	
٦	0.045	0.060	1.15	1.52	
N	0.190	0.210	4.83	5.33	
Q	0.100	0.120	2.54	3.04	
R	0.080	0.110	2.04	2.79	
S	0.045	0.055	1.15	1.39	
Т	0.235	0.255	5.97	6.47	
U	0.000	0.050	0.00	1.27	
٧	0.045		1.15		
Z		0.080		2.04	

STYLE 5: PIN 1. GATE

- DRAIN
- 3 SOURCE DRAIN

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